Local Feature Detectors

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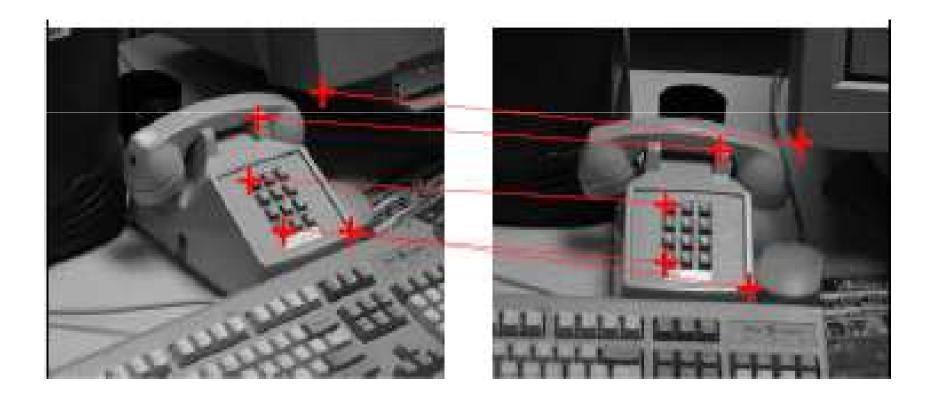
Slides adapted from Cordelia Schmid and David Lowe, CVPR 2003 Tutorial, Matthew Brown, Microsoft Research, and Steve Seitz, U of Washington.

Image matching

- Image matching is a fundamental aspect of many problems in computer vision.
 - Object or scene recognition
 - Solving for 3D structure from multiple images
 - Stereo correspondence
 - Image alignment & stitching
 - Image indexing and search
 - Motion tracking
- Find "interesting" pieces of the image.
 - Focus attention of algorithms
 - Speed up computation



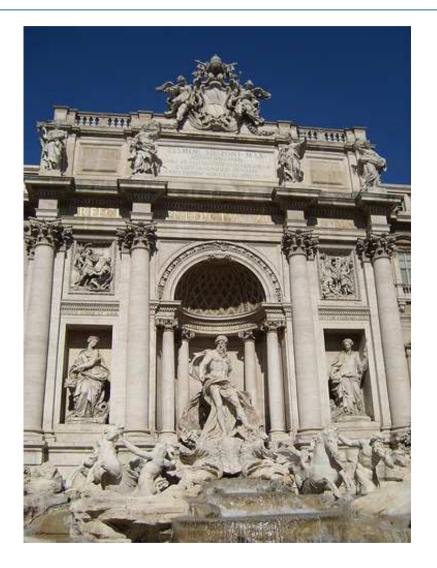
Object recognition: Find correspondences between feature points in training and test images.



3D reconstruction: find correspondences between feature points in two images of the same scene.



Two images of Rome from Flickr





Two images of Rome from Flickr: harder case



Two images from NASA Mars Rover: even harder case

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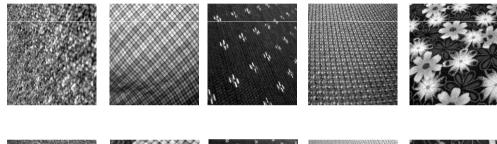
Two images from NASA Mars Rover: matching using local features

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Stereo correspondence



Recognition



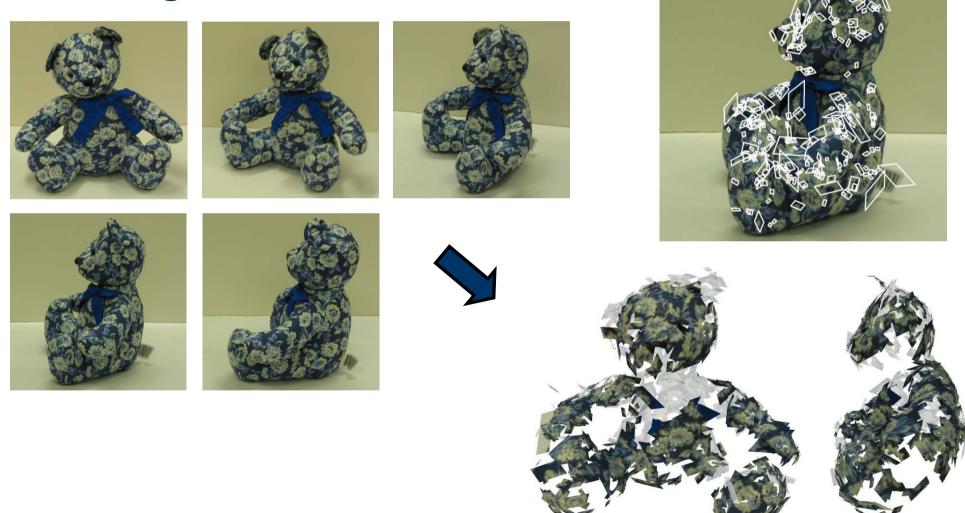


Texture recognition



Car detection

3D recognition



Advantages of local features

- Locality
 - features are local, so robust to occlusion and clutter
- Distinctiveness
 - can differentiate a large database of objects
- Quantity
 - hundreds or thousands in a single image
- Efficiency
 - real-time performance achievable
- Generality
 - exploit different types of features in different situations

Local features

- What makes a good feature?
- We want uniqueness.
 - Look for image regions that are unusual.
 - Lead to unambiguous matches in other images.
- How to define "unusual"?

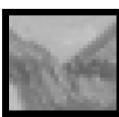


OD structure→ not useful for matching



1D structure

edge, can be localized in 1D, subject to the aperture problem



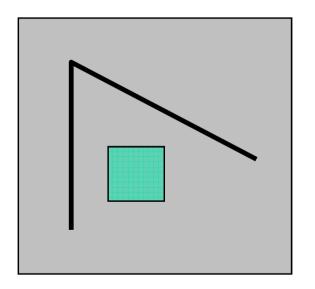
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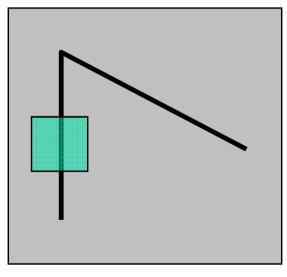
2D structure

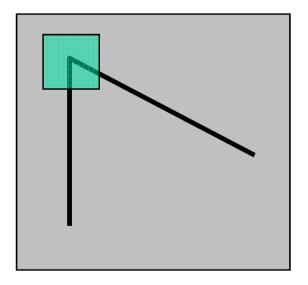
 corner, can be localized in 2D, good for matching

Local measures of uniqueness

- Suppose we only consider a small window of pixels.
 - What defines whether a feature is a good or bad candidate?



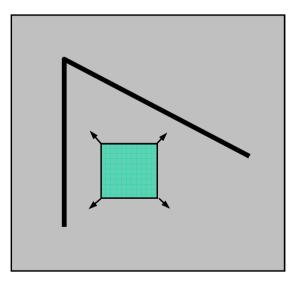




Local measures of uniqueness

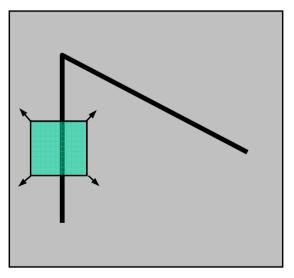
Local measure of feature uniqueness:

- How does the window change when you shift it?
- Shifting the window in *any direction* causes a *big change*.



"flat" region: no change in all directions

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"edge": no change along the edge direction

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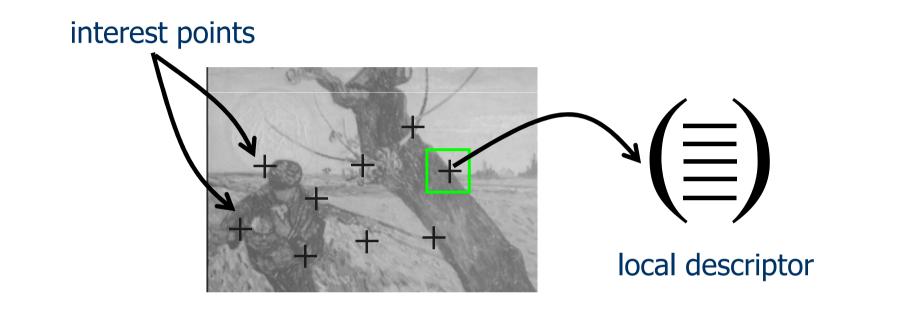
"corner": significant change in all directions

Local features and image matching

- There are three important requirements for feature points to have a better correspondence for matching:
 - Points corresponding to the same scene points should be detected consistently over different views.
 - They should be invariant to image scaling, rotation and to change in illumination and 3D camera viewpoint.
 - There should be enough information in the neighborhood of the points so that corresponding points can be automatically matched.

These points are also called interest points.

Overview of the approach



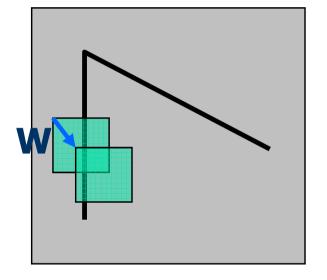
- 1. Extraction of interest points (characteristic locations).
- 2. Computation of local descriptors.
- 3. Determining correspondences.
- 4. Using these correspondences for matching/recognition/etc.

- Consider shifting the window W by (u,v):
 - How do the pixels in W change?
 - Auto-correlation function measures the self similarity of a signal and is related to the sum-of-squared difference.
 - Compare each pixel before and after the shift by summing up the squared differences (SSD).



$$E(u,v) = \sum_{(x,y)\in W} \left[I(x+u,y+v) - I(x,y) \right]^2$$





Taylor Series expansion of I:

 $I(x+u, y+v) = I(x, y) + \frac{\partial I}{\partial x}u + \frac{\partial I}{\partial y}v + \text{higher order terms}$

 If the motion (u,v) is assumed to be small, then first order approximation is good.

$$I(x + u, y + v) \approx I(x, y) + \frac{\partial I}{\partial x}u + \frac{\partial I}{\partial y}v$$
$$\approx I(x, y) + [I_x \ I_y] \begin{bmatrix} u \\ v \end{bmatrix}$$
shorthand: $I_x = \frac{\partial I}{\partial x}$

Plugging this into the formula on the previous slide...

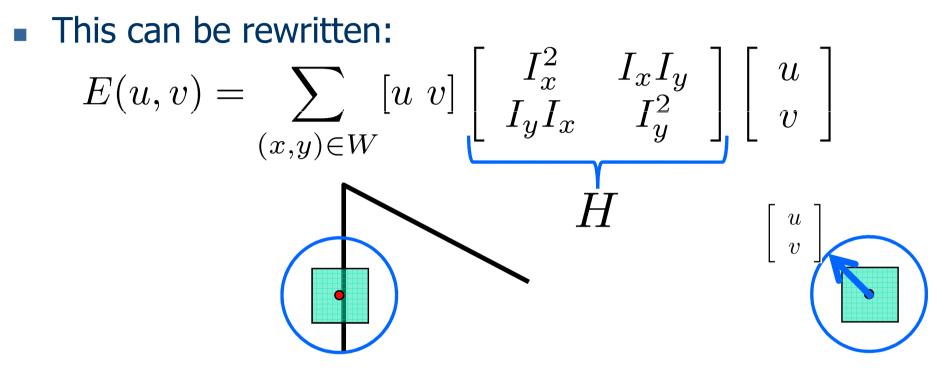
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Sum-of-squared differences error E(u,v):

$$E(u,v) = \sum_{(x,y)\in W} [I(x+u,y+v) - I(x,y)]^2$$

$$\approx \sum_{(x,y)\in W} \left[I(x,y) + \left[I_x \ I_y \right] \left[\begin{array}{c} u \\ v \end{array} \right] - I(x,y) \right]^2$$

$$\approx \sum_{(x,y)\in W} \left[\begin{bmatrix} I_x & I_y \end{bmatrix} \begin{bmatrix} u \\ v \end{bmatrix} \right]^2$$



- For the example above:
 - You can move the center of the green window to anywhere on the blue unit circle.
 - Which directions will result in the largest and smallest E values?
 - We can find these directions by looking at the eigenvectors of **H**.

Quick eigenvector/eigenvalue review

• The eigenvectors of a matrix **A** are the vectors **x** that satisfy:

$$Ax = \lambda x$$

- The scalar λ is the eigenvalue corresponding to **x**
 - The eigenvalues are found by solving:

$$det(A - \lambda I) = 0$$

In our case, A = H is a 2x2 matrix, so we have

$$det \begin{bmatrix} h_{11} - \lambda & h_{12} \\ h_{21} & h_{22} - \lambda \end{bmatrix} = 0$$

• The solution:

$$\lambda_{\pm} = \frac{1}{2} \left| (h_{11} + h_{22}) \pm \sqrt{4h_{12}h_{21} + (h_{11} - h_{22})^2} \right|$$

• Once you know λ , you find **x** by solving

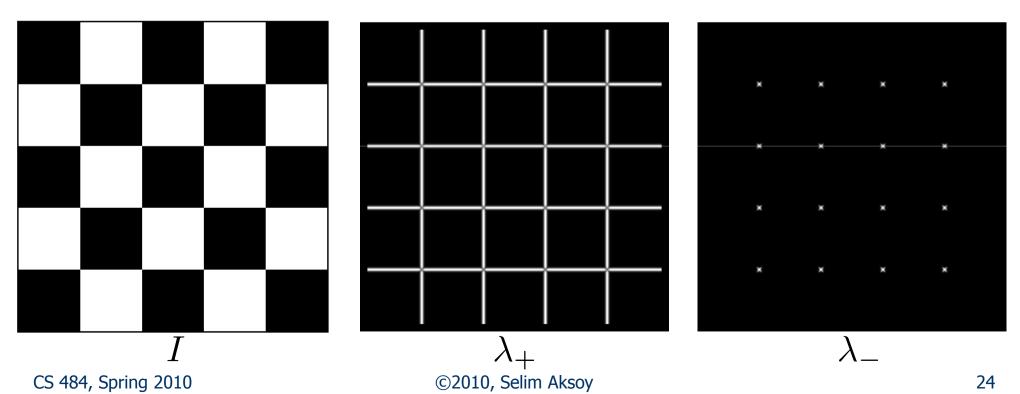
$$\begin{bmatrix} h_{11} - \lambda & h_{12} \\ h_{21} & h_{22} - \lambda \end{bmatrix} \begin{bmatrix} x \\ y \end{bmatrix} = 0$$

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- This can be rewritten: $E(u,v) = \sum_{(x,y)\in W} \begin{bmatrix} u & v \end{bmatrix} \begin{bmatrix} I_x^2 & I_x I_y \\ I_y I_x & I_y^2 \end{bmatrix} \begin{bmatrix} u \\ v \end{bmatrix}$ H $\begin{bmatrix} u \\ v \end{bmatrix}$
- Eigenvalues and eigenvectors of H:
 - Define shifts with the smallest and largest change (E value).
 - x₊ = direction of largest increase in E.
 - λ_+ = amount of increase in direction x_+ .
 - x₋ = direction of smallest increase in E.
 - λ_{-} = amount of increase in direction x₋.

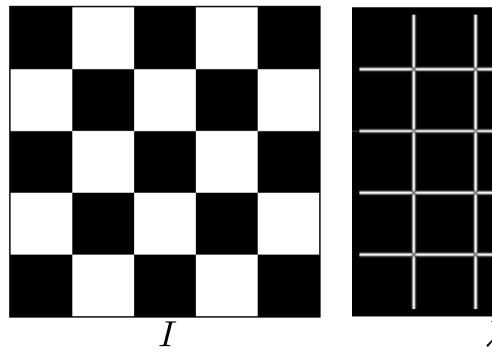
 $Hx_{+} = \lambda_{+}x_{+}$ $Hx_{-} = \lambda_{-}x_{-}$

- How are λ_+ , x_+ , λ_- , and x_- relevant for feature detection?
 - What's our feature scoring function?
- Want E(u,v) to be large for small shifts in all directions.
 - The minimum of E(u,v) should be large, over all unit vectors [u v].
 - This minimum is given by the smaller eigenvalue (λ_{-}) of **H**.

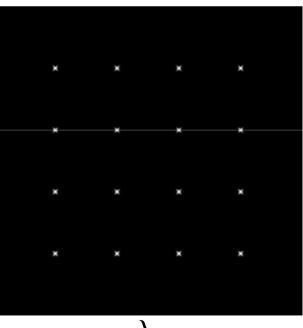


- Here's what you do:
 - Compute the gradient at each point in the image.
 - Create the H matrix from the entries in the gradient.
 - Compute the eigenvalues.
 - Find points with large response (λ_{-} > threshold).
 - Choose those points where λ_{-} is a local maximum as features.

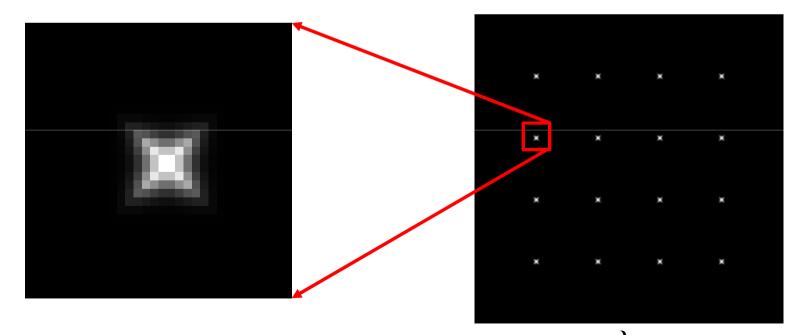
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- Here's what you do:
 - Compute the gradient at each point in the image.
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 - Compute the eigenvalues.
 - Find points with large response (λ_{-} > threshold).
 - Choose those points where λ_{-} is a local maximum as features.



Harris detector

• To measure the corner strength:

$$R = det(H) - k(trace(H))^2$$

where

trace(H) = $\lambda_1 + \lambda_2$

 $det(H) = \lambda_1 \times \lambda_2$

(λ_1 and λ_2 are the eigenvalues of H).

- R is positive for corners, negative in edge regions, and small in flat regions.
- Very similar to λ_{-} but less expensive (no square root).
- Also called the "Harris Corner Detector" or "Harris Operator".
- Lots of other detectors, this is one of the most popular.

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Harris detector

1. Compute x and y derivatives of image

$$I_x = G^x_\sigma * I \quad I_y = G^y_\sigma * I$$

 Compute products of derivatives at every pixel

$$I_{x2} = I_x I_x \quad I_{y2} = I_y I_y \quad I_{xy} = I_x I_y$$

Compute the sums of the products of derivatives at each pixel

$$S_{x2} = G_{\sigma'} * I_{x2}$$
 $S_{y2} = G_{\sigma'} * I_{y2}$ $S_{xy} = G_{\sigma'} * I_{xy}$

4. Define at each pixel (x, y) the matrix

$$H(x,y) = \begin{bmatrix} S_{x2}(x,y) & S_{xy}(x,y) \\ S_{xy}(x,y) & S_{y2}(x,y) \end{bmatrix}$$

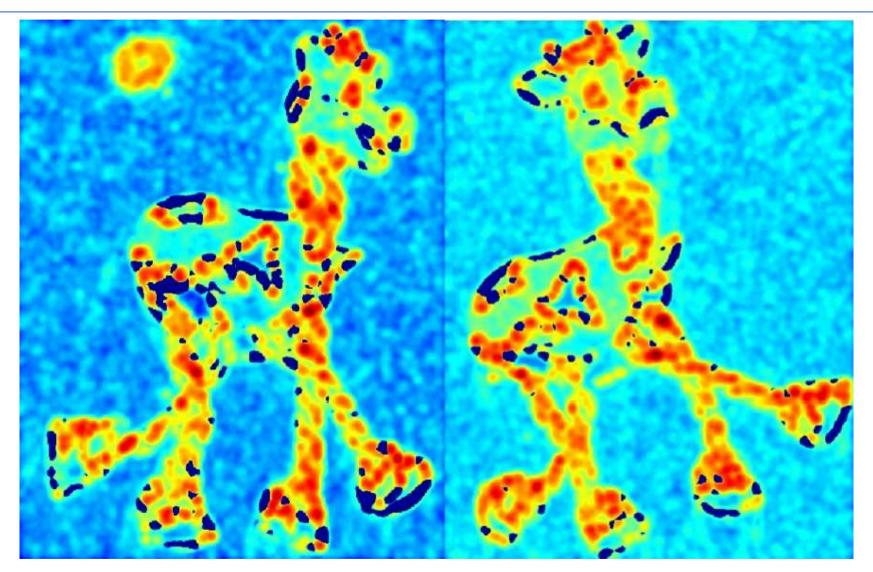
Compute the response of the detector at each pixel

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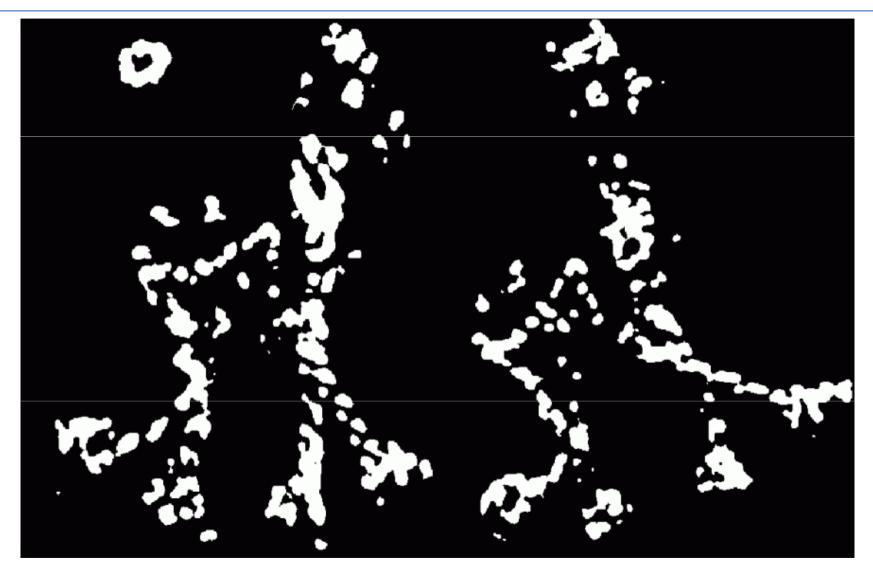
$$R = Det(H) - k(Trace(H))^2$$

28





R values (red high, blue low)



Threshold (R > value)

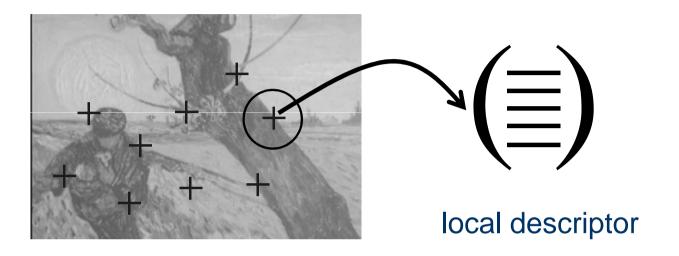
·	
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Local maxima of R



Harris features (red)

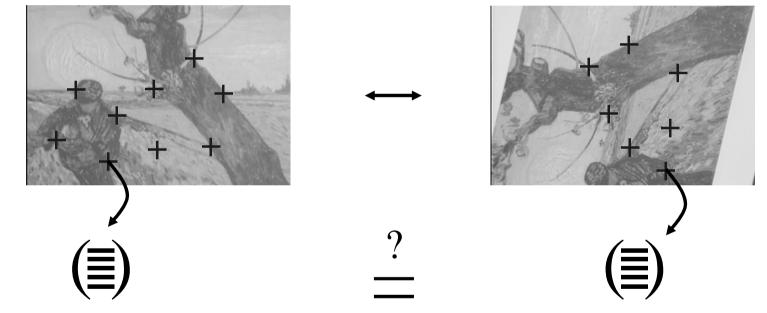
Local features: descriptors



- Descriptors characterize the local neighborhood of a point.
 - Gray values within a square window around the point can be used directly.
 - Gray value derivatives or differential invariants can also be used.

Local features: matching

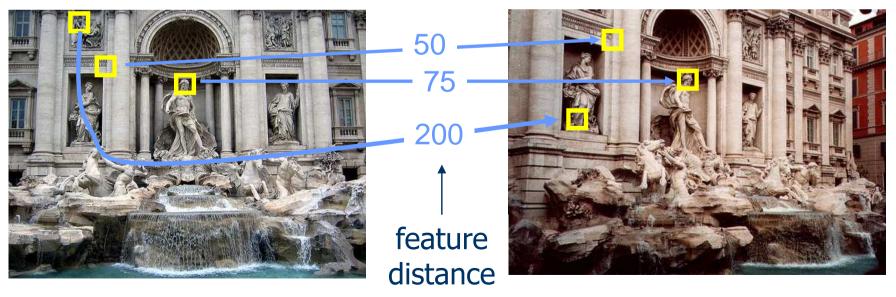
We know how to detect good features.Next question: how to match them?



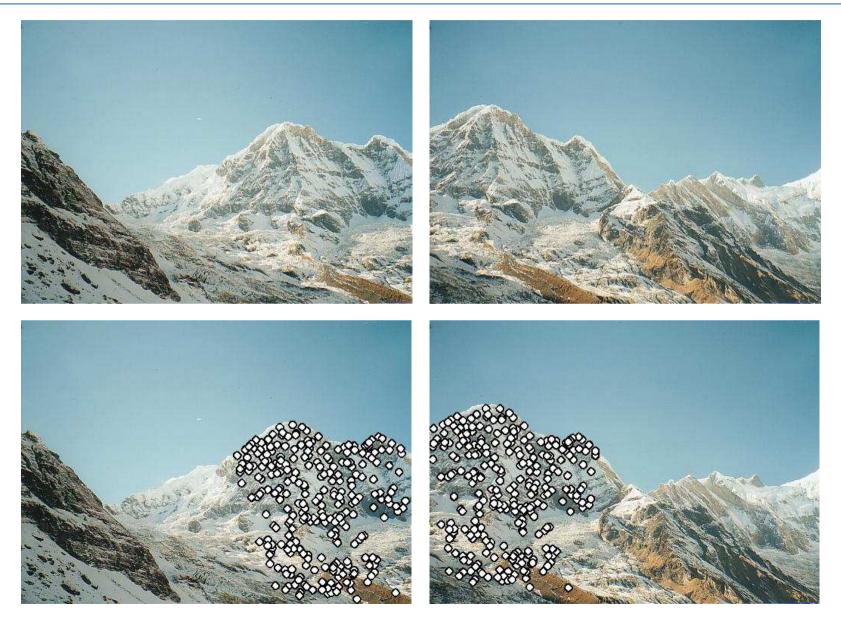
 Vector comparison using a distance measure can be used.

Local features: matching

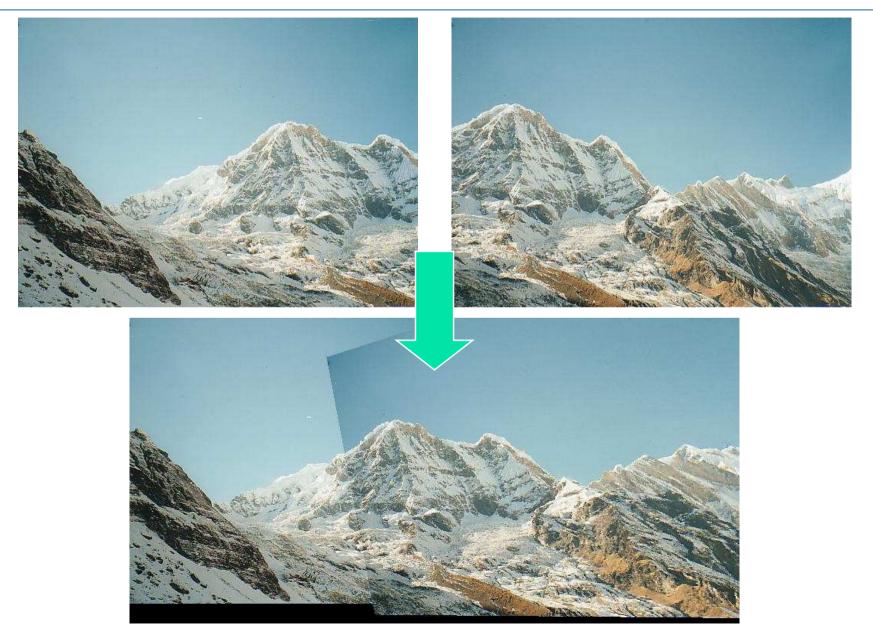
- Given a feature in I₁, how to find the best match in I₂?
 - 1. Define a distance function that compares two descriptors.
 - 2. Test all the features in I_2 , find the one with minimum distance.



Matching examples



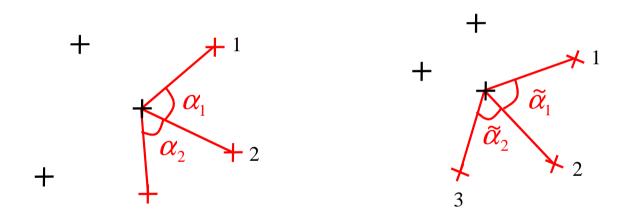
Matching examples



Local features: matching

Matches can be improved using local constraints

- neighboring points should match
- angles, length ratios should be similar



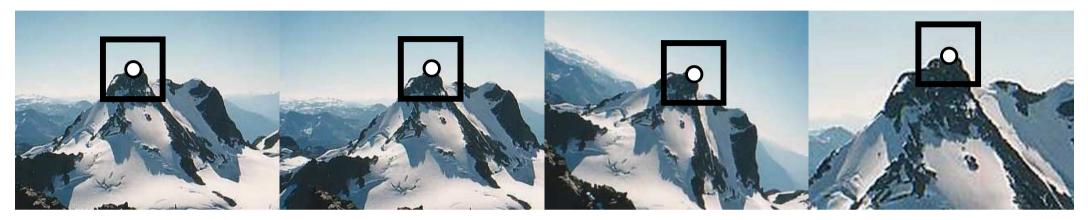
Summary of the approach

- Detection of interest points/regions
 - Harris detector
 - Blob detector based on Laplacian
- Computation of descriptors for each point
 - Gray value patch, differential invariants, steerable filter, SIFT descriptor
- Similarity of descriptors
 - Correlation, Mahalanobis distance, Euclidean distance
- Semi-local constraints
 - Geometrical or statistical relations between neighborhood points
- Global verification
 - Robust estimation of geometry between images

Local features: invariance

- Suppose you rotate the image by some angle.
 - Will you still pick up the same features?
- What if you change the brightness?
- What about scale?
- We'd like to find the same features regardless of the transformation.
 - This is called transformational invariance.
 - Most feature methods are designed to be invariant to
 - Translation, 2D rotation, scale.
 - They can usually also handle
 - Limited 3D rotations (SIFT works up to about 60 degrees).
 - Limited affine transformations (some are fully affine invariant).

Local features: invariance



original

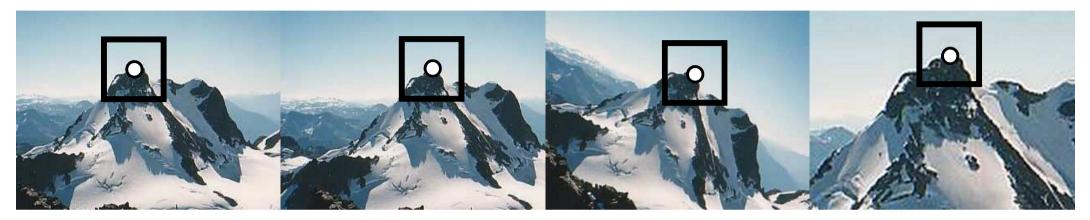
translated

rotated

scaled

	Translation	Rotation	Scale
Is Harris invariant?	?	?	?
Is correlation invariant?	?	?	?

Local features: invariance



original

translated

rotated

```
scaled
```

	Translation	Rotation	Scale
Is Harris invariant?	YES	YES	NO
Is correlation invariant?	YES	NO	NO

How to achieve invariance?

Need both of the following:

- 1. Make sure your detector is invariant.
 - Harris is invariant to translation and rotation.
 - Scale is trickier.
 - Common approach is to detect features at many scales using a Gaussian pyramid (e.g., MOPS).
 - More sophisticated methods find "the best scale" to represent each feature (e.g., SIFT).
- 2. Design an invariant feature descriptor.
 - A descriptor captures the information in a region around the detected feature point.
 - The simplest descriptor: a square window of pixels.
 - What's this invariant to?
 - Let's look at some better approaches...

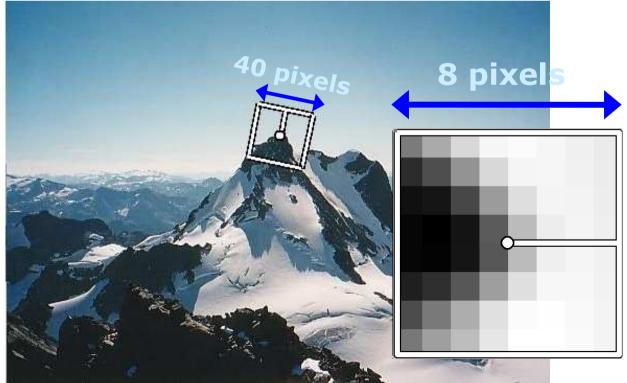
Rotation invariance for descriptors

- Find dominant orientation of the image patch.
 - This is given by x₊, the eigenvector of H corresponding to λ₊ (larger eigenvalue).
 - Rotate the patch according to this angle.



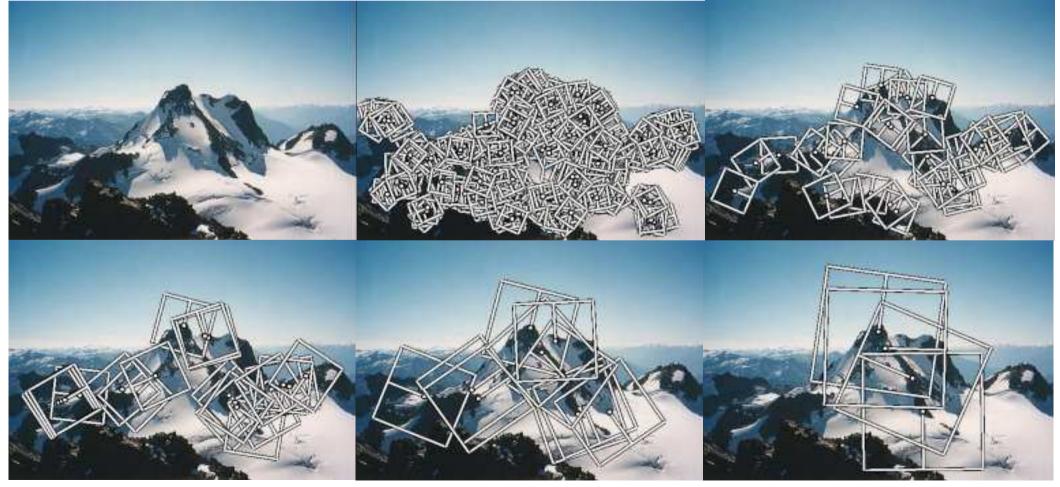
Multi-scale Oriented Patches (MOPS)

- Take 40x40 square window around detected feature.
 - Scale to 1/5 size (using prefiltering).
 - Rotate to horizontal.
 - Sample 8x8 square window centered at feature.
 - Intensity normalize the window by subtracting the mean, dividing by the standard deviation in the window.



Multi-scale Oriented Patches (MOPS)

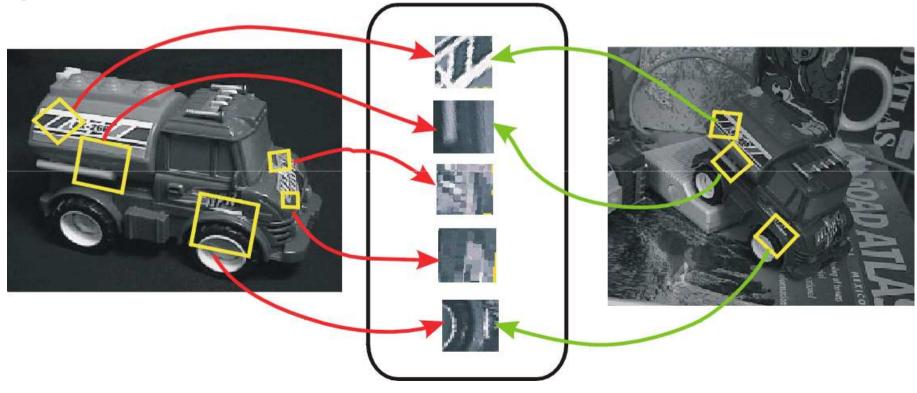
 Extract oriented patches at multiple scales of the Gaussian pyramid.



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Scale Invariant Feature Transform (SIFT)

 The SIFT operator developed by David Lowe is both a detector and a descriptor that are invariant to translation, rotation, scale, and other imaging parameters.



Overall approach for SIFT

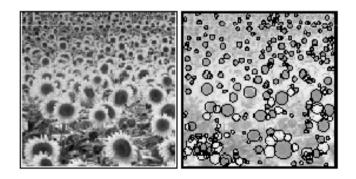
- 1. Scale space extrema detection
 - Search over multiple scales and image locations.
- 2. Interest point localization
 - Fit a model to determine location and scale.
 - Select interest points based on a measure of stability.
- 3. Orientation assignment
 - Compute best orientation(s) for each interest point region.
- 4. Interest point description
 - Use local image gradients at selected scale and rotation to describe each interest point region.

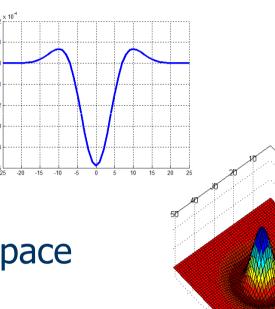
Scale space extrema detection

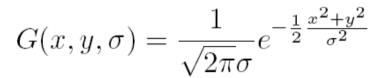
- Goal: Identify locations and scales that can be repeatably assigned under different views of the same scene or object.
- Method: search for stable features across multiple scales using a continuous function of scale.
- Prior work has shown that under a variety of assumptions, the best function is a Gaussian function.
- The scale space of an image is a function L(x,y,σ) that is produced from the convolution of a Gaussian kernel (at different scales) with the input image.

Scale space interest points

- Laplacian of Gaussian kernel
 - Scale normalized
 - Proposed by Lindeberg
- Scale space detection
 - Find local maxima across scale/space
 - A good "blob" detector







$$\nabla^2 G(x, y, \sigma) = \frac{\partial^2 G}{\partial x^2} + \frac{\partial^2 G}{\partial y^2}$$

Scale space interest points

- Scale space function L
 - Gaussian convolution

$$G(x, y, \sigma) = \frac{1}{2\pi\sigma^2} e^{-(x^2 + y^2)/2\sigma^2}$$

 $L(x, y, \sigma) = G(x, y, \sigma) * I(x, y)$, where σ is the width of the Gaussian

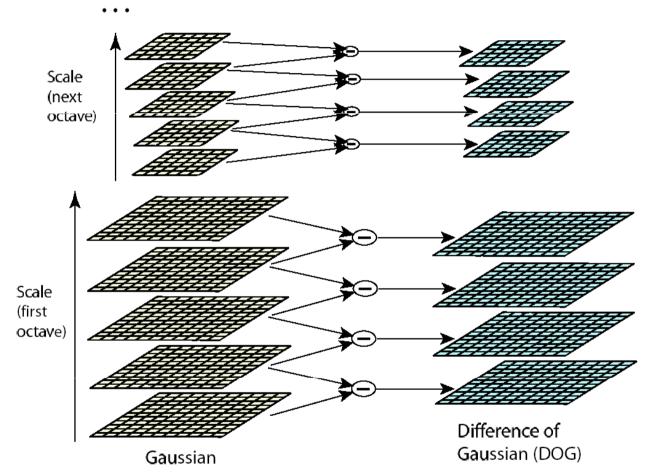
 Difference of Gaussian kernel is a close approximation to scalenormalized Laplacian of Gaussian.

$$D(x, y, \sigma) = (G(x, y, k\sigma) - G(x, y, \sigma)) * I(x, y)$$

= $L(x, y, k\sigma) - L(x, y, \sigma)$. 2 scales: σ and $k\sigma$

 Can approximate the Laplacian of Gaussian kernel with a difference of separable convolutions.

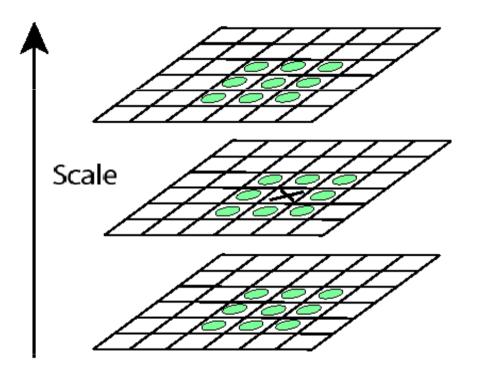
Lowe's pyramid scheme



For each octave of scale space, the initial image is repeatedly convolved with Gaussian to produce the set of scale space images (left). Adjacent Gaussian images are subtracted to produce difference of Gaussian images (right). After each octave Gaussian image is downsampled by a factor of 2.

Interest point localization

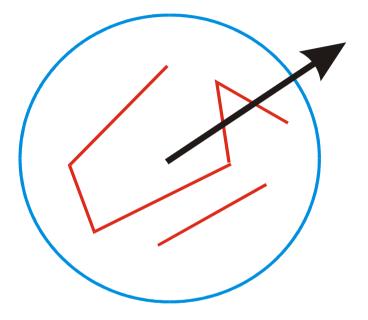
- Detect maxima and minima of difference of Gaussian in scale space.
- Each point is compared to its 8 neighbors in the current image and 9 neighbors each in the scales above and below.
- Select only if it is greater or smaller than all the others.

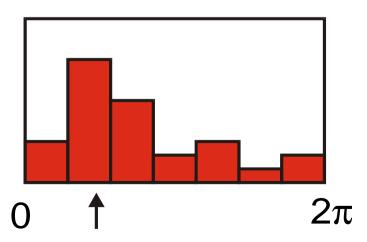


 For each max or min found, output is the location and the scale.

Orientation assignment

- Create histogram of local gradient directions computed at selected scale.
- Assign canonical orientation at peak of smoothed histogram.
- Each key specifies stable 2D coordinates (x, y, scale, orientation).





Interest point descriptors

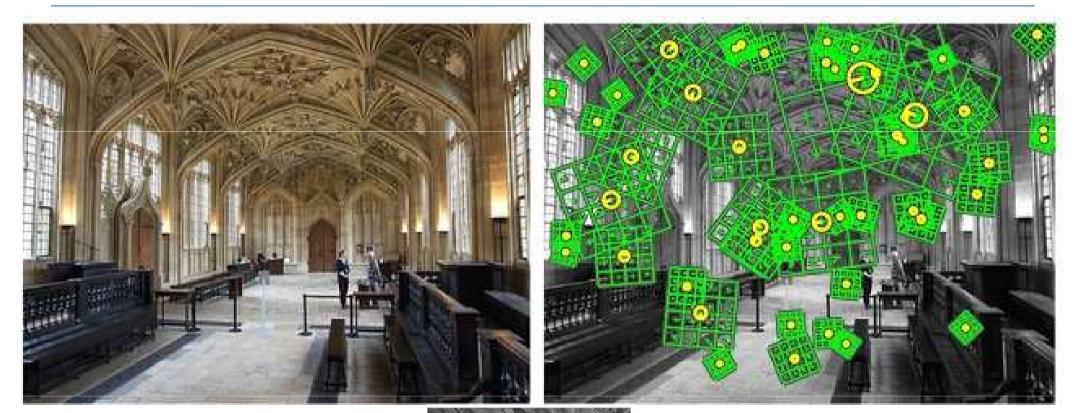
At this point, each interest point has

- location,
- scale,
- orientation.
- Next step is to compute a descriptor for the local image region about each interest point that is
 - highly distinctive,
 - invariant as possible to variations such as changes in viewpoint and illumination.

Lowe's interest point descriptor

- Use the normalized circular region about the interest point.
 - Rotate the window to standard orientation.
 - Scale the window size based on the scale at which the point was found.
- Compute gradient magnitude and orientation at each point in the region.
- Weight them by a Gaussian window overlaid on the circle.
- Create an orientation histogram over the 4x4 subregions of the window.
- 4x4 descriptors over 16x16 sample array were used in practice. 4x4 times 8 directions gives a vector of 128 values.

Lowe's interest point descriptor



An input image



Overlayed descriptors

Adapted from www.vlfeat.org

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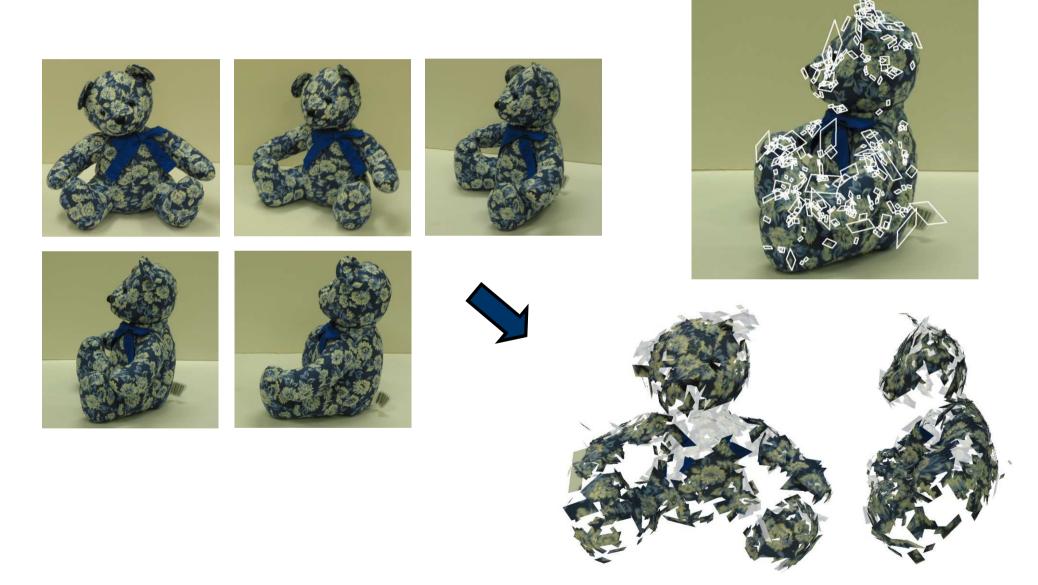
Example applications

- Object and scene recognition
- Stereo correspondence
- 3D reconstruction
- Image alignment & stitching
- Image indexing and search
- Motion tracking
- Robot navigation

Examples: 3D recognition



Examples: 3D reconstruction

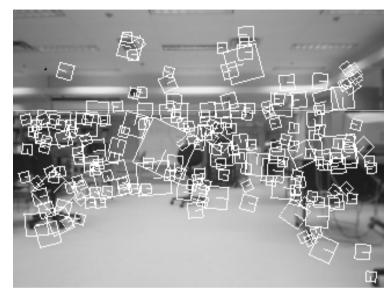


Examples: location recognition

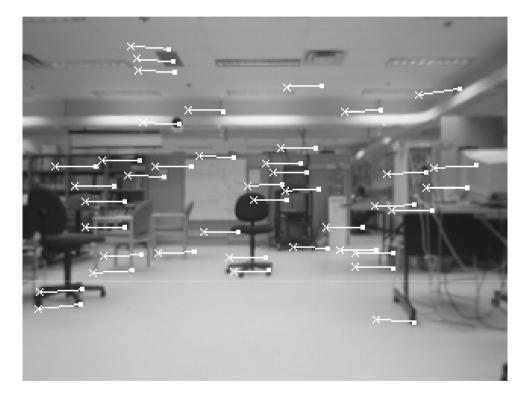


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Examples: robot localization

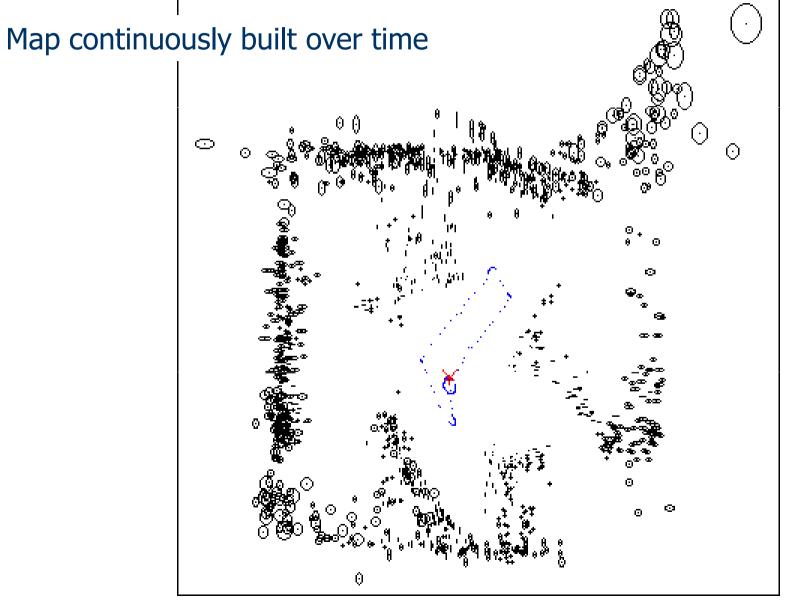






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Examples: robot localization



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Examples: panaromas

- Recognize overlap from an unordered set of images and automatically stitch together.
- SIFT features provide initial feature matching.
- Image blending at multiple scales hides the seams.



Panorama of Lowe's lab automatically assembled from 143 images

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Examples: panaromas

Image registration and blending



(a) 40 of 80 images registered



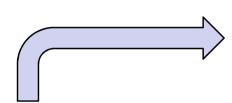
(b) All 80 images registered



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(c) Rendered with multi-band blending

Examples: panaromas





25 of 57 images aligned





All 57 images aligned



Final result

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Sony Aibo

AIBO® Entertainment Robot

Official U.S. Resources and Online Destinations

SIFT usage:

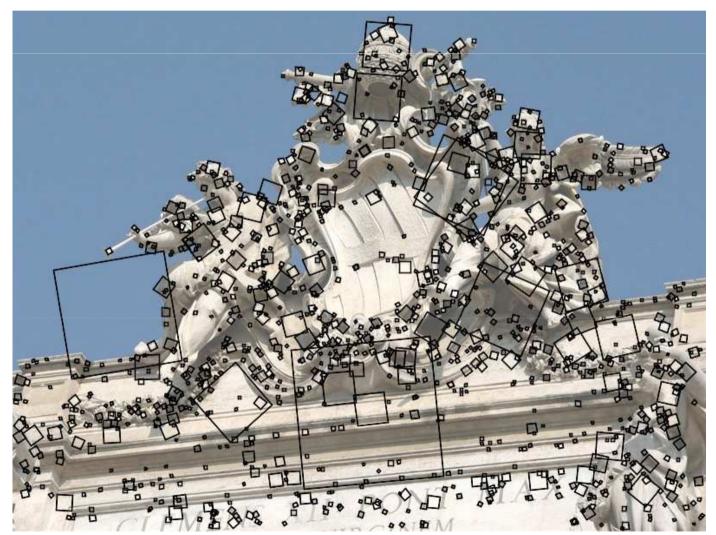
- Recognize charging station
- Communicate with visual cards
- Teach object recognition



- Joint work by University of Washington and Microsoft Research
 - <u>http://phototour.cs.washington.edu/</u>
 - <u>http://research.microsoft.com/IVM/PhotoTours/</u>
- Photosynth Technology Preview at Microsoft Live Labs
 - <u>http://labs.live.com/photosynth/</u>

Don't forget to check the cool video and demo at <u>http://phototour.cs.washington.edu/</u>.

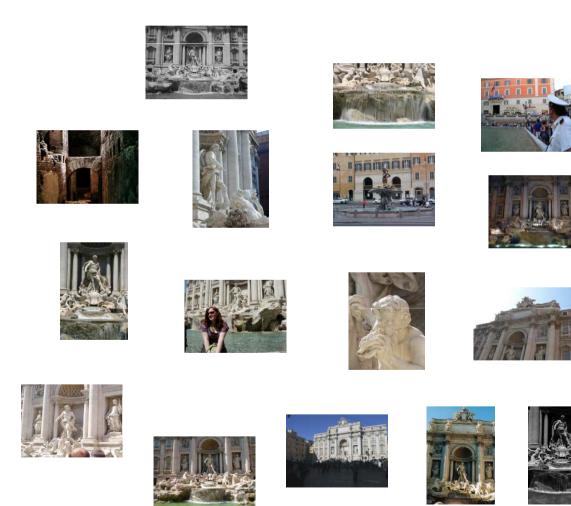
Detect features using SIFT.



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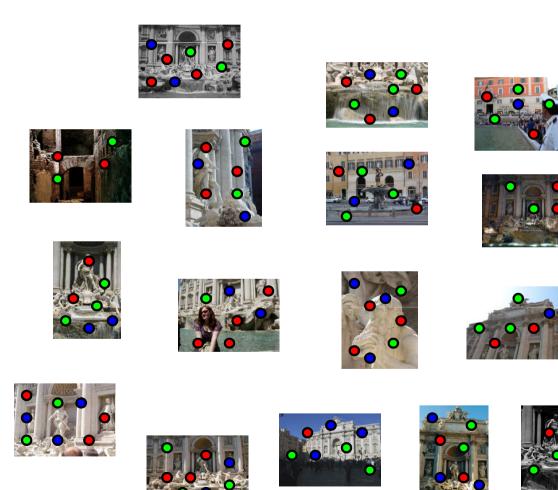
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Detect features using SIFT.



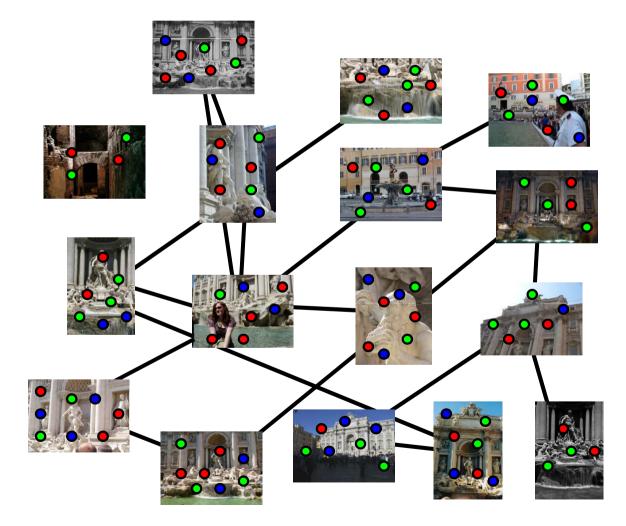


Detect features using SIFT.

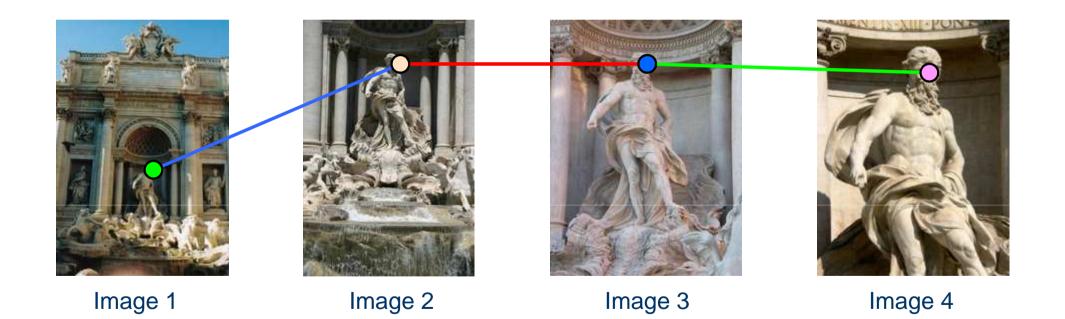


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Match features between each pair of images.

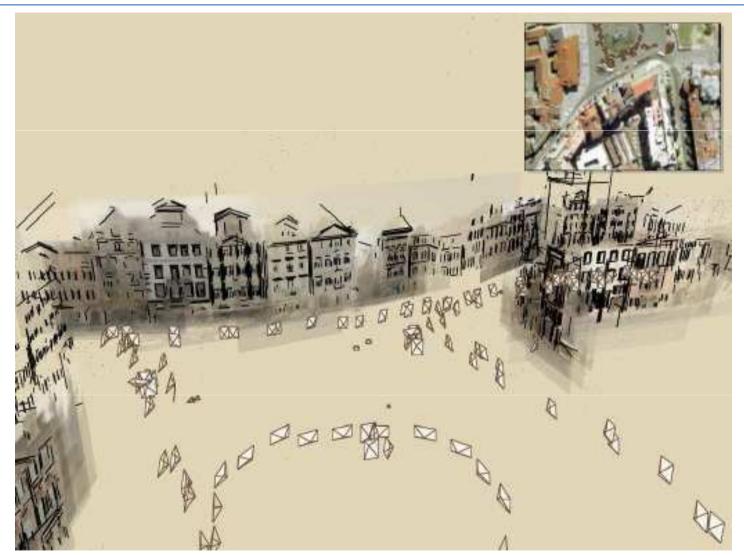


 Link up pairwise matches to form connected components of matches across several images.





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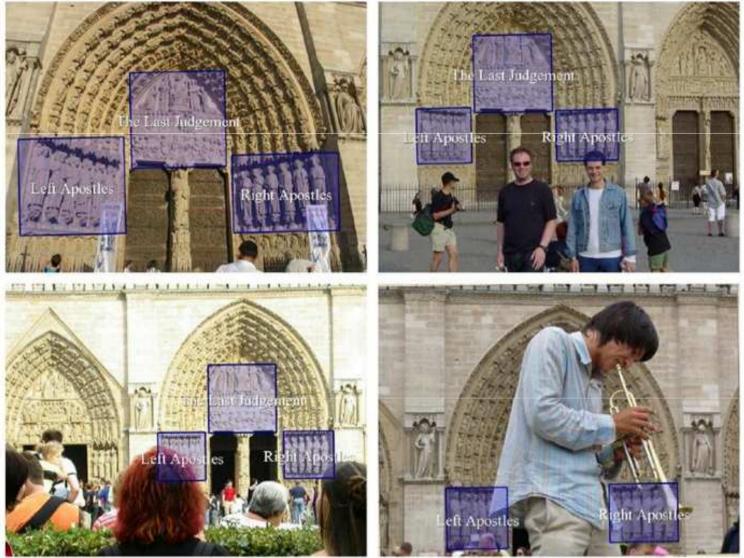
Photos are automatically placed inside a sketchy 3D model of the scene; an optional overhead map also shows each photo's location. CS 484, Spring 2010 ©2010, Selim Aksoy



An info pane on the left shows information about the current image and navigation buttons for moving around the collection; the filmstrip view on the bottom shows related images; mousing over these images brings them up as a registered overlay. CS 484, Spring 2010 ©2010, Selim Aksoy



Photographs can also be taken in outdoor natural environments. The photos are correctly placed in 3-D, and more free-form geometric models can be used for inter-image transitions. CS 484, Spring 2010 ©2010, Selim Aksoy

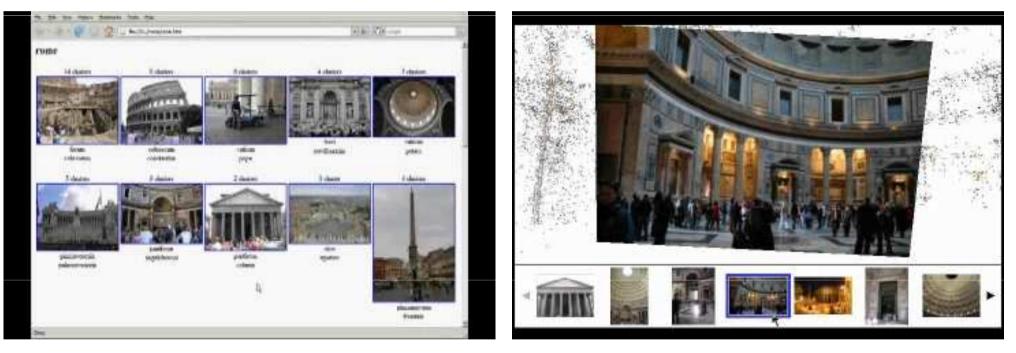


Annotations entered in one image (upper left) are automatically transferred to all other related images.

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Scene summarization for online collections

http://grail.cs.washington.edu/projects/canonview



Scene summary browsing

Enhanced 3D browsing